


<b>Search Notes</b>  	<b>Application/Control No.</b>  10742891	<b>Applicant(s)/Patent Under Reexamination</b>  AIZAWA ET AL.
	<b>Examiner</b>  Whipkey, Jason T	<b>Art Unit</b>  2622

SEARCHED			
Class	Subclass	Date	Examiner
348	207.1	2/27/2007	JTW
348	231.2	2/27/2007	JTW
348	231.7	2/27/2007	JTW
348	231.8	2/27/2007	JTW
348	231.9	2/27/2007	JTW
348	207.99	2/27/2007	JTW

SEARCH NOTES		
Search Notes	Date	Examiner
Reviewed wrappers for parent applications 08/215,625; 08/462,846; 08/790,056; 08/790,062; 09/127,603; 09/481,598	2/26/07	JTW
Text search	2/23/07	JTW
Talked to Ngoc-Yen Vu (AU 2622)	3/28/07	JTW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See interference search printout	3/16/2007	JTW